Test Beam Results on Focusing Aerogel

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Outline

- Test beam facility
- Aerogel and photodetectors description
- Test beam measurements
- Recalculation for SuperB FARICH based on test beam results.
- Plans

Test beam experiment



Test beam parameters:

- "Converter mode", ~10 mA, 3.5 GeV beam in VEPP-4M, -- ~50 Hz of 1.3 GeV secondary electrons (3 GeV maximum)
- 50x15 mm² beam crossection (defined by trigger counter dimentions)
- ~0.5 mm track spatial resolution



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Test beam line



Aerogel sample



	n	h, mm
Layer 1	1.050	6.2
Layer 2	1.041	7.0
Layer 3	1.035	7.7
Layer 4	1.030	9.7



Lsc(400nm)=43 mm

n²=1+0.438*ρ

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MRS APD Parameters





- Producer Center of Perspective Technology and Apparatus – CPTA, Moscow http://www.spta-apd.ru/
- Genuine name MRS APD (other names: silicon photomultiplier, PPD,MPPC...)
- 2.1x2.1 mm sensor
- 4x4 mm case size
- PDE=40% @ 600 nm (?)
- Gain ~ 4.10⁵
- Time resolution ~100 ps
- Dark counts ~5--10 MHz (0.5pe threshold)

Photodetectors layout



SiPM coordinates and trigger area



Electrons could pass at different distances from SiPM.

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Event selection





• We select events with $|t-t_{ch}| < 3\sigma_t$

Cherenkov ring radius measurement(1)

(X,Y)hit-(X,Y)track

$$R^{2} = (X_{hit} - X_{track})^{2} + (Y_{hit} - Y_{track})^{2}$$



Cherenkov ring radius measurement(2)



Difference between σ_r and σ_r (sim) comes mainly from track resolution (~0.5 mm)



 $\begin{array}{l} 22.1-21.5=0.6 \text{ mm} \ -> 2.7\% \\ \text{Position accuracy} \ -> 1.7\% \\ \text{error in } n_{\text{aerogel}} \text{ from dencuty} \ -> \end{array}$

What PID will be at SuperB with such aerogel?





• Pure Gaussian + flat background (from randome coincedence with G-APD noise) at least in $\pm 5\sigma$ region.

•
$$\sigma_r^2 = \sigma_{aerogel}^2 + \sigma_{pixel}^2 + \sigma_{track}^2$$

• $\sigma'_{aerogel} = sqrt(\sigma_r^2 - \sigma_{pixel}^2)$
= $sqrt(1.09^2 - 2.1^2/12) = 0.91 mr$

PID with $\sigma'_{aerogel}$ =0.91 mm and 6 mm pixel. Estimation of lower limit of PID.

Plans

- Continue data analysis collected during test beam experiment.
 - List of measured samples:
 - 2 single layer aerogels
 - 2 4-layer aerogels
 - 1 2-layer aerogel
 - water (5 mm)
 - List of experiments:
 - 3 to 5 positions in focusing mode
 - 2 positions in defocusing mode
 - surface scan of 4-layer aerogel
- Planacon PMTs
- Electronics
- Mechanics



Conclusion

- Test beam measurements of 4-layer aerogel give us a lot of information on focusing radiator
- Test beam results confirm earlier MC simulations.

Additional slides

Signal fit function

 $\frac{dN_{hit}}{dx \, dy \, dx' \, dy'}(x, y, x', y') = \frac{dN_{trk}}{dx \, dy}(x, y) \frac{dN_{p.e.}}{dx' \, dy'}(x'-x, y'-y),$ x, y - track coordinates; x', y' - photon coordinates

If we integrate on x', y' over active area of a particular pixel and assume symmetry on φ , we deduce

$$\frac{dN_{hit}}{dx\,dy}(x,y) \approx \frac{dN_{trk}}{dx\,dy}(x,y) S_{px} \frac{dN_{p.e.}}{dx'\,dy'}(r) = \frac{dN_{trk}}{dx\,dy}(x,y) \frac{S_{px}}{2\pi r} \frac{dN_{p.e.}}{dr}(r),$$

$$r = \sqrt{(x_{px} - x)^2 + (y_{px} - y)^2} - \text{distance from pixel center to track,}$$

$$S_{px} - \text{pixel active area.}$$

In some cases p.e. distribution can be described by a gaussian:

$$\frac{dN_{p.e.}}{dr}(r) = \frac{N_{p.e.}}{\sqrt{2\pi\sigma_r}} \exp\left(-\frac{(r-r_c)^2}{2\sigma_r^2}\right)$$

Fitting procedure (1)

Break track and hit distributions in 2D bins: $N_{hit}(i, j)$, $N_{trk}(i, j)$,

i, j – indices of bins on x and y with centers x_i, y_j

Mean number of hits $v_{hit}(i, j)$ is described by

$$v_{hit}(i,j) = N_{trk}(i,j) \left(\frac{S_{px}}{2\pi r_{ij}} \frac{N_{p.e.}}{\sqrt{2\pi}\sigma_r} \exp\left(-\frac{(r_{ij}-r_c)^2}{2\sigma_r^2} \right) + B \right),$$

 r_{ij} – distance from bin center to pixel center

B – background parameter

 $N_{hit}(i, j)$ is Poisson random number with mean $v_{hit}(i, j)$, hence we use likelihood function

$$-\ln L = \sum_{i, j} (v_{hit}(i, j) - N_{hit}(i, j) \ln v_{hit}(i, j)).$$

By the fit we determine parameters: $N_{p.e.}$, r_c , σ_r , B, ΔX , ΔY , for each pixel (channel).

 $\varDelta \, X$, $\varDelta \, Y$ – shift of FARICH r.f. relative to DCH r.f.

Fitting procedure (2)

- Also we can do a global fit for all channels with common parameters r_c , σ_r , ΔX , ΔY
- Having determined r.f. shift, we can build hit and track distributions on radius $N_{hit}(r_i)$, $N_{trk}(r_i)$ and fit them:

$$\frac{dN_{p.e.}}{dr}(r_i) + \frac{2\pi r B}{S_{px}} = \frac{2\pi r N_{hit}(r_i)}{S_{px}N_{trk}(r_i)}$$

- Background is not very well fitted with single parameter B in a large area 30x15 mm of track positions for some channels.
 Probable reasons:
 - Cross-talks between channels
 - Non-linearities in DCH track position determination
 - → Use fits on radius in a narrower region $\pm 5\sigma_r$ around the ring.

Number of photoelectrons (4-layer)



Discrepancy between Npe in simulation and experiment could be explained by:

- real detection efficiency of G-APDs is smaller than in data book
- electronics miscount

Number of photoelectrons (1-layer)



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Single layer vs 4-layer aerogel

Single layer aerogel measurement



- 'Focusing' effect 3 times decrease in ring width :
 - 2 cm thickness, single layer $\rightarrow \sigma r=2.1$ mm
 - 3 cm thickness, 4 layer -> σr=1.1 mm

Defocusing measurements, 2-layer block



 Such measurements give direct answer what is the index of refraction of each layer.

FARICH layout



- MCP PMT photodetectors -Photonis XP85012
- Radiator Focusing Aerogel + NaF

laye	er	marerial	n(400n m)	t, mm
1		aerogel	1.039	16.2
2		aerogel	1.050	13.8
3		NaF	1.332	5.0

 X/X0 = 2.4%(aerogel) + 4.3%(NaF) + 10%(PMT) + ~ 8% (support,FEE,cooling) ≈ 25%

Photodetector



- Number of PMTs: 312
- Number of anodes: 8×8
- 6×6 mm anode size
- 59×59×13 mm case dimensions
- 81% active area fraction
- 70% MCP photoelectron collection
- QE(400nm)=29%
- Gain ~ $5 \cdot 10^5$;
- Time resolution \sim 40 ps;

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Monte Carlo Simulation



Number of photoelectrons

 π/K separation of FARICH in comparison with FDIRC and DCH

K/p separation of FARICH in Comparison with DCH

Cost estimation

Component	Unit price, kEuro	Cost, kEuro
Photonis MCP PMT*	6.5	2300
2-layer aerogel	3.0	400
NaF	2.0	200
Electronics		300
Mechanics		100
R&D		100
Total		3400

(*) - based on price of PMTs with 25mkm MCPs

Test beam apparatus



Electronics

- Fast FPGA are used as TDC:
 - Smaller number of components it is easier to fit FARICH electronics into available space
 - zero dead time
 - Flexible logic
 - Commercially available
 - Low cost (~0.5 Euro/channel)
- FE ASIC several candidates:
 - NINO13 (new version, designed for use with pixel MCP PMTs!)
 - DIRC ASIC

Matthieu Despeisse et.al., "Low-Power Amplifier-Discriminators For High Time Resolution Detection", IEEE TRANSACTIONS ON NUCLEAR SCIENCE, VOL. 56, NO. 2, APRIL 2009

Electronics layout

One sector:

- 26 PMTs with 64 channels = 1664 channels
- FE ASIC (NINO13) 5x7 mm frame, 8 channels, 1664/8 = 208 chips on board
- FPGA TDC (Cyclone III) 23x23 mm frame, 60 channels, 1664/60 – 28 chips on board
- 10 Gb optical link(XFP)

Is it possible to fit all this on single PCB or we need 2 PCBs?

Electronics layout (front view)



50 W heat dissipation per PCB

water cooling

Electronics layout (side view)



- We need only one PCB for signal digitization and readout
- Aluminum cooling board with water channels is coupled to PCB. 1 mm thickness (1% of X0)
- Separate connector board for each PMT is foreseen. It is used also to arrange HV divider.
- 46 mm total thickness
- Radiation hardness of FPGAs need to be investigated:
 - Total dose and particle flux in the forward?
 - Radiation hardness of Cyclone III and other FPGAs

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